

# SKiM429GD17E4HD



SKiM<sup>®</sup> 93

## Trench IGBT Modules

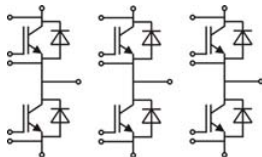
### SKiM429GD17E4HD

#### Features

- IGBT 4 Trench Gate Technology
- Solderless sinter technology
- Low inductance case
- Isolated by AL<sub>2</sub>O<sub>3</sub> DCB (Direct Copper Bonded) ceramic substrate
- Pressure contact technology for thermal contacts and electrical contacts
- High short circuit capability, self limiting to 6 x I<sub>C</sub>
- Integrated temperature sensor

#### Typical Applications

- Automotive inverter
- High reliability AC inverter wind
- High reliability AC inverter drives



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#### Absolute Maximum Ratings

Symbol	Conditions	Values	Unit	
<b>IGBT</b>				
V <sub>CEs</sub>		1700	V	
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>s</sub> = 25 °C	595	A
		T <sub>s</sub> = 70 °C	479	A
I <sub>Cnom</sub>		420	A	
I <sub>CRM</sub>	I <sub>CRM</sub> = 3xI <sub>Cnom</sub>	1260	A	
V <sub>GES</sub>		-20 ... 20	V	
t <sub>psc</sub>	V <sub>CC</sub> = 1200 V V <sub>GE</sub> ≤ 15 V V <sub>CEs</sub> ≤ 1700 V	T <sub>j</sub> = 150 °C	10	μs
T <sub>j</sub>		-40 ... 175	°C	
<b>Inverse diode</b>				
I <sub>F</sub>	T <sub>j</sub> = 150 °C	T <sub>s</sub> = 25 °C	413	A
		T <sub>s</sub> = 70 °C	298	A
I <sub>Fnom</sub>		450	A	
I <sub>FRM</sub>	I <sub>FRM</sub> = 2xI <sub>Fnom</sub>	900	A	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C	3699	A	
T <sub>j</sub>		-40 ... 150	°C	
<b>Module</b>				
I <sub>t(RMS)</sub>		700	A	
T <sub>stg</sub>		-40 ... 125	°C	
V <sub>isol</sub>	AC sinus 50 Hz, t = 1 min	3300	V	

#### Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
<b>IGBT</b>					
V <sub>CE(sat)</sub>	I <sub>C</sub> = 420 A V <sub>GE</sub> = 15 V chipllevel	T <sub>j</sub> = 25 °C	1.90	2.25	V
		T <sub>j</sub> = 125 °C	2.1	2.3	V
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C	1.1	1.2	V
		T <sub>j</sub> = 125 °C	1	1.1	V
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25 °C	1.9	2.5	mΩ
		T <sub>j</sub> = 125 °C	2.6	2.9	mΩ
V <sub>GE(th)</sub>	V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 16.8 mA	5.2	5.8	6.4	V
I <sub>CES</sub>	V <sub>GE</sub> = 0 V V <sub>CE</sub> = 1700 V	T <sub>j</sub> = 25 °C	0.15	0.45	mA
					mA
C <sub>ies</sub>	V <sub>CE</sub> = 25 V		33		nF
C <sub>oes</sub>	V <sub>GE</sub> = 0 V		1.38		nF
C <sub>res</sub>			1.08		nF
Q <sub>G</sub>	V <sub>GE</sub> = - 8 V...+ 15 V		6660		nC
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C		2.7		Ω
t <sub>d(on)</sub>	V <sub>CC</sub> = 1200 V	T <sub>j</sub> = 125 °C	390		ns
t <sub>r</sub>	I <sub>C</sub> = 420 A	T <sub>j</sub> = 125 °C	80		ns
E <sub>on</sub>	R <sub>G on</sub> = 3.6 Ω	T <sub>j</sub> = 125 °C	245		mJ
t <sub>d(off)</sub>	R <sub>G off</sub> = 3.6 Ω	T <sub>j</sub> = 125 °C	1005		ns
t <sub>f</sub>	di/dt <sub>on</sub> = 5200 A/μs di/dt <sub>off</sub> = 2200 A/μs	T <sub>j</sub> = 125 °C	170		ns
		T <sub>j</sub> = 125 °C	180		mJ
E <sub>off</sub>			180		mJ
R <sub>th(j-s)</sub>	per IGBT		0.079		K/W

# SKiM429GD17E4HD



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## Trench IGBT Modules

### SKiM429GD17E4HD

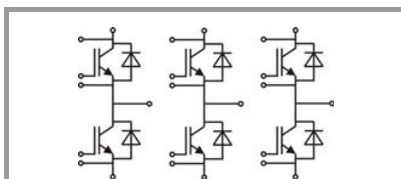
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Inverse diode</b>						
V <sub>F</sub> = V <sub>EC</sub>	I <sub>F</sub> = 420 A	T <sub>j</sub> = 25 °C		1.7	1.9	V
	V <sub>GE</sub> = 0 V chip	T <sub>j</sub> = 125 °C		1.6	1.8	V
V <sub>F0</sub>		T <sub>j</sub> = 25 °C		1.1	1.3	V
		T <sub>j</sub> = 125 °C		0.9	1.1	V
r <sub>F</sub>		T <sub>j</sub> = 25 °C		1.3	1.3	mΩ
		T <sub>j</sub> = 125 °C		1.8	1.8	mΩ
I <sub>RRM</sub>	I <sub>F</sub> = 420 A	T <sub>j</sub> = 125 °C		500		A
Q <sub>rr</sub>	di/dt <sub>off</sub> = 5990 A/μs	T <sub>j</sub> = 125 °C		140		μC
E <sub>rr</sub>	V <sub>GE</sub> = -15 V	T <sub>j</sub> = 125 °C		99		mJ
	V <sub>CC</sub> = 1200 V					
R <sub>th(j-s)</sub>	per diode				0.169	K/W
<b>Module</b>						
L <sub>CE</sub>				10	15	nH
R <sub>CC+EE'</sub>	terminal-chip	T <sub>s</sub> = 25 °C		0.3		mΩ
		T <sub>s</sub> = 125 °C		0.5		mΩ
M <sub>s</sub>	to heat sink (M4)		2.5		4	Nm
M <sub>t</sub>	to terminals (M6)		3		5	Nm
w					1100	g
<b>Temperature sensor</b>						
R <sub>100</sub>	T <sub>Sensor</sub> = 100 °C (R <sub>25</sub> = 5 kΩ)			339		Ω
B <sub>100/125</sub>	R <sub>(T)</sub> = R <sub>100</sub> exp[B <sub>100/125</sub> (1/T-1/373)]; T[K];			4096		K



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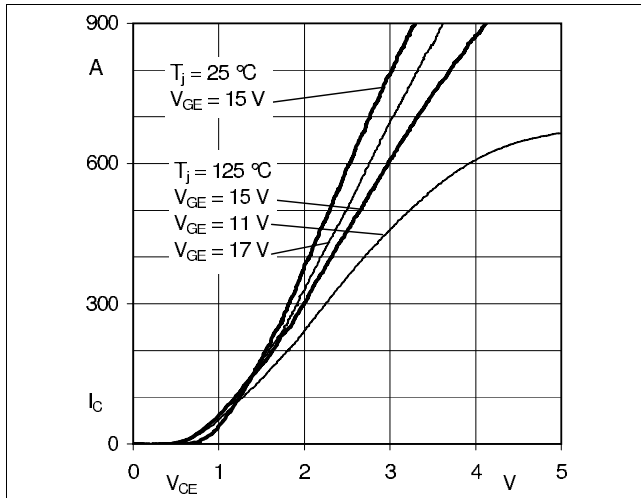


Fig. 1: Typ. output characteristic, inclusive  $R_{CC+EE'}$

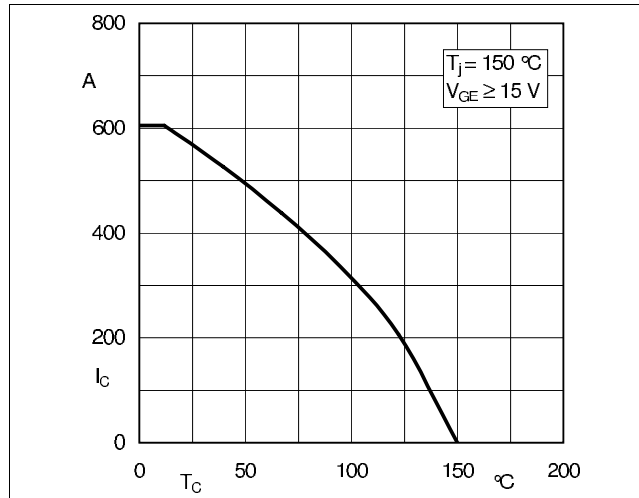


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

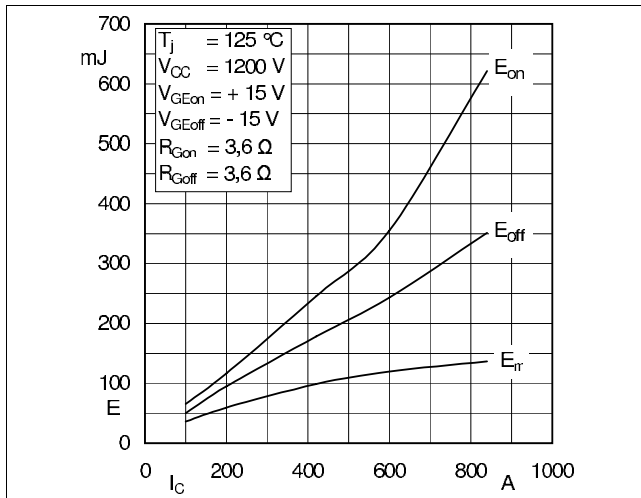


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

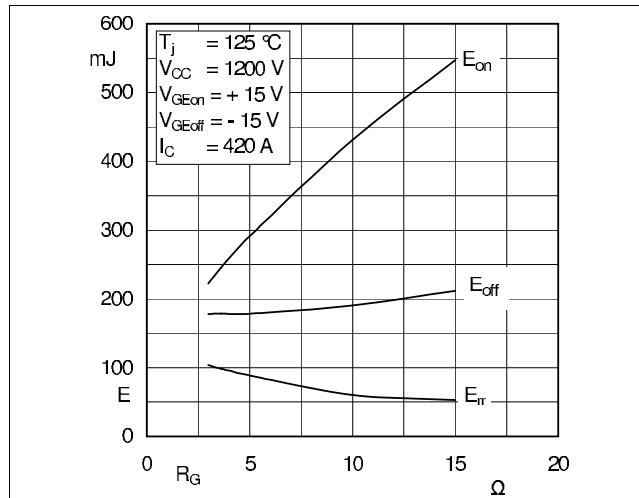


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

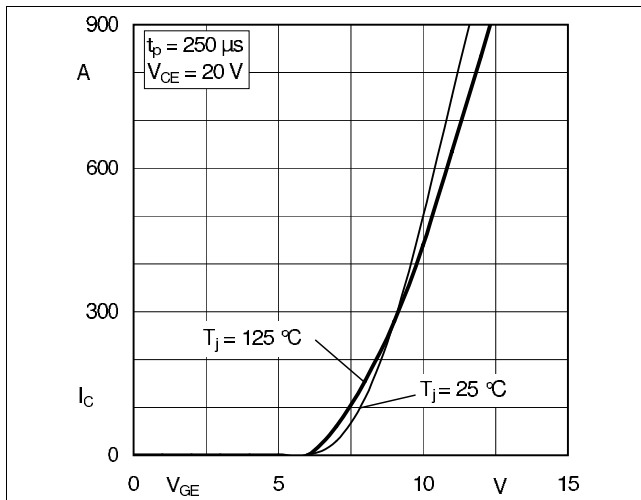


Fig. 5: Typ. transfer characteristic

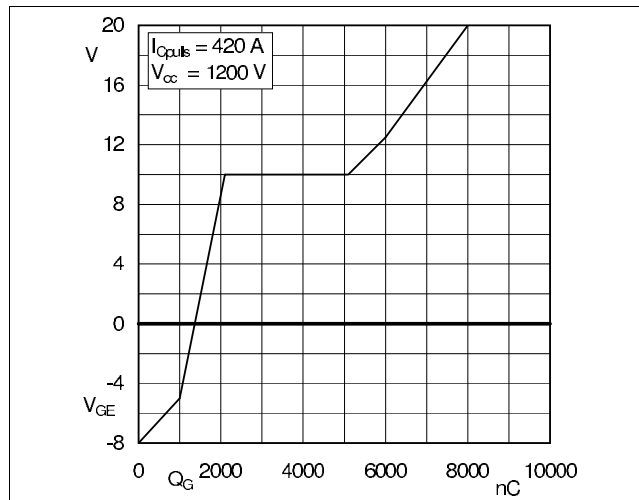


Fig. 6: Typ. gate charge characteristic

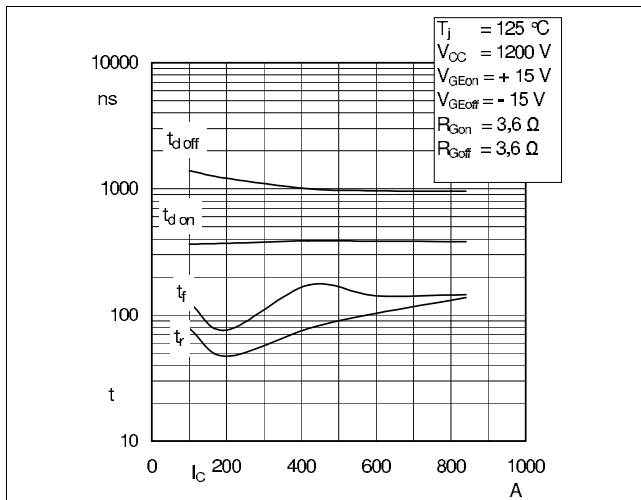


Fig. 7: Typ. switching times vs.  $I_C$

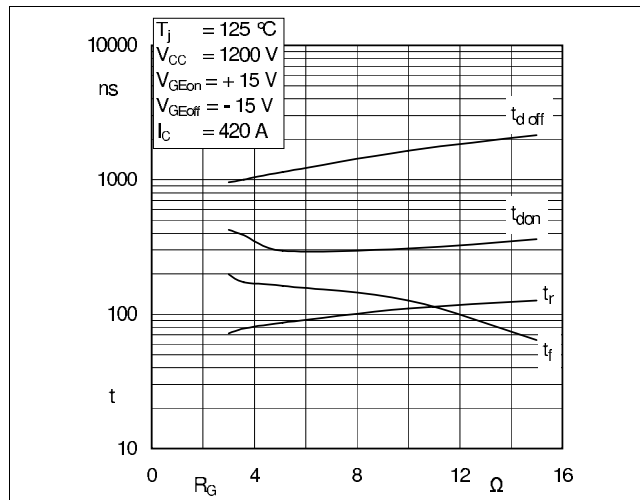


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

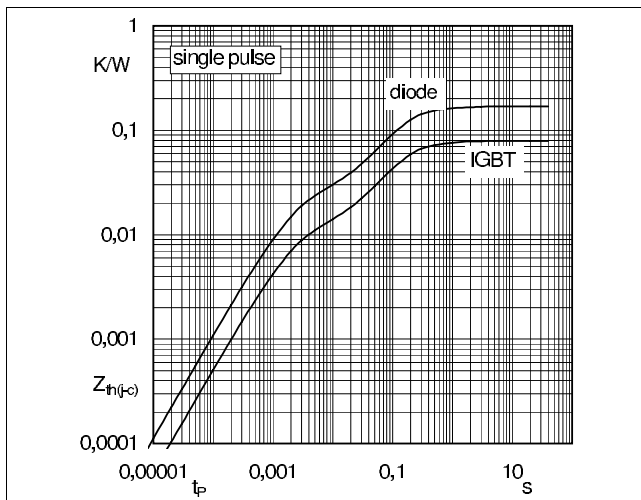


Fig. 9: Typ. transient thermal impedance

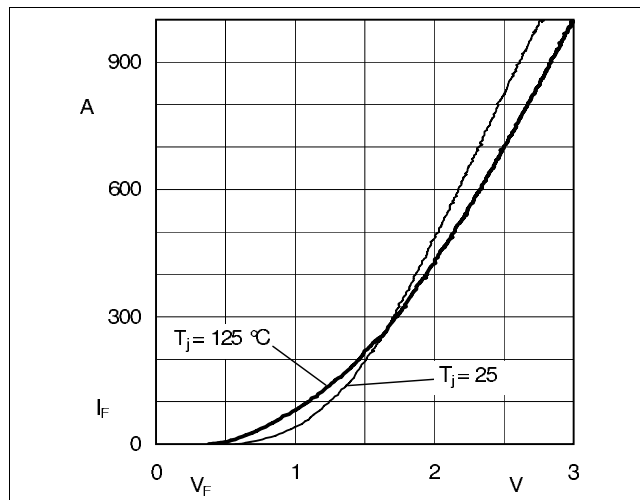


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC+EE'}$

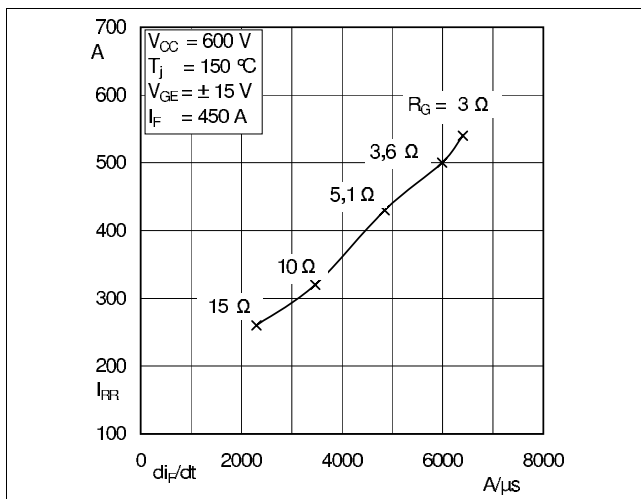


Fig. 11: Typ. CAL diode peak reverse recovery current

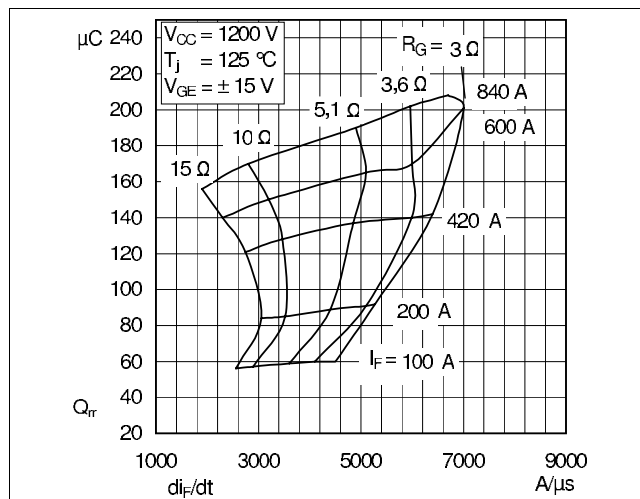
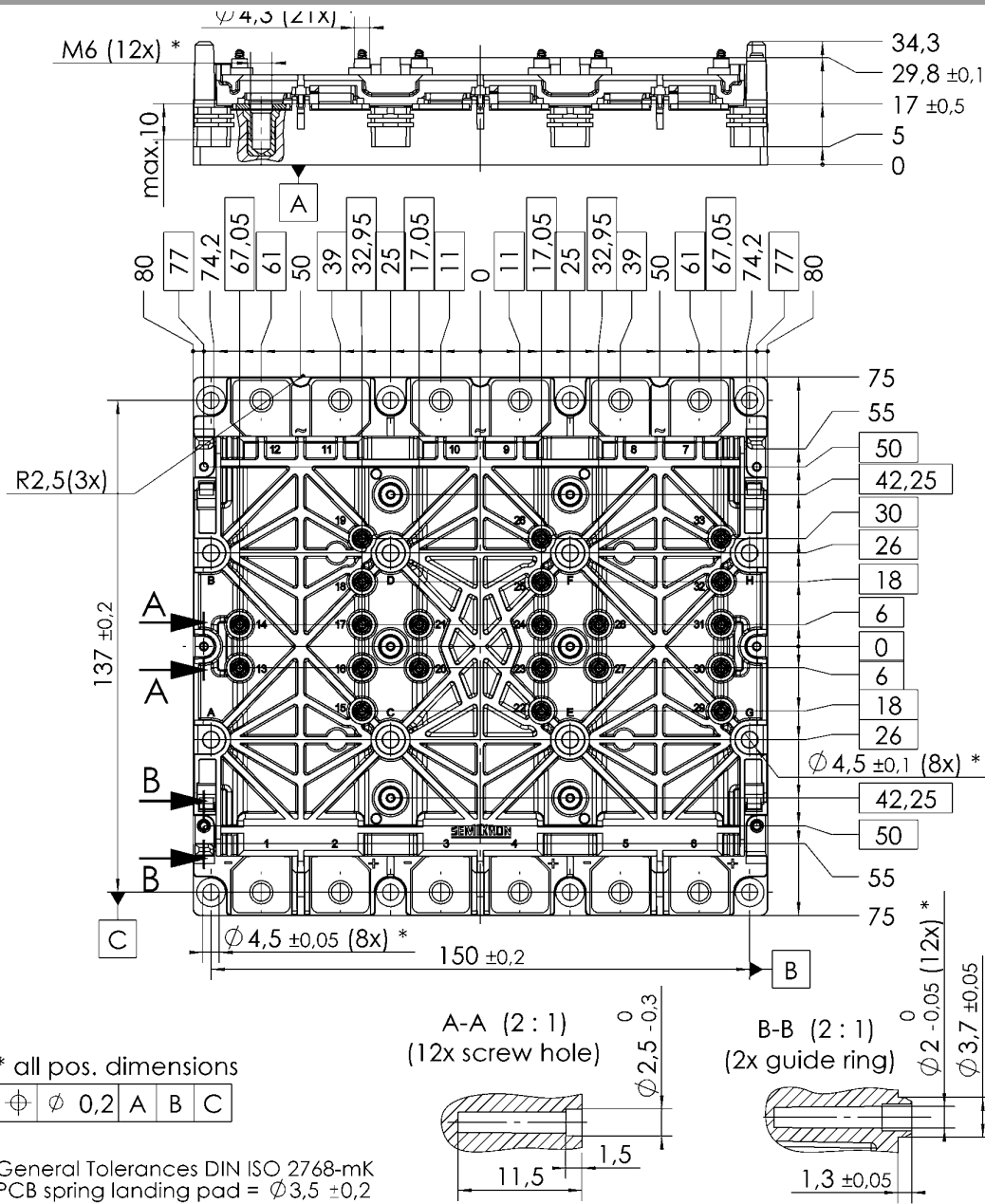
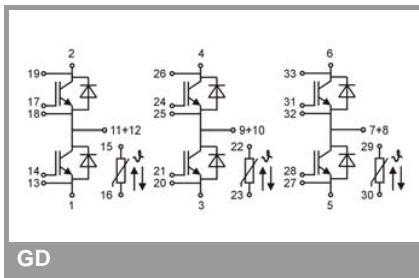


Fig. 12: Typ. CAL diode recovery charge

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